Notice of References Cited Application/Control No. 10/659,213 Examiner Jason Heckert Applicant(s)/Patent Under Reexamination MIYA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,807,974	10-2004	Ono et al.	134/153
*	В	US-6,332,723	12-2001	Matsuyama et al.,	396/571
*	С	US-4,903,717	02-1990	Sumnitsch, Franz	134/99.1
*	D	US-6,672,318	01-2004	Tsuchiya et al.	134/147
	Е	US-			
	F	US-		,	
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.